# Phase Locked Loops in Fully Integrated NB-IoT Transceivers

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# **Abstract**

This thesis investigates how to fulfill the Narrow Band - Internet of Things (NB-IoT) specification for a fully integrated transceiver in the phase locked loop's (PLL) perspective. Designing a fully integrated transceiver, integrating a power amplifier (PA) is challenging as it leads to frequency pulling of the voltage controlled oscillator (VCO) in the PLL, deteriorating the performance. By increasing the bandwidth of the PLL, the frequency pulling can be suppressed, especially when the bandwidth is increased to at least twice the baseband bandwidth. The frequency pulling can be further suppressed by designing the PA balun in such a way that a common mode current cancels as well as designing the VCO inductor in an eight shape fashion, reducing the coupling from balun to inductor. The NB-IoT specification is extracted from 3GPP and translated to a phase noise requirement for the PLL and a parameterization of the PLL is made to ease the evaluation of the phase noise performance.

 ${\it Keywords:}$  Phase locked loops, Narrow Band Internet of Things, Frequency pulling, Balun, Inductor

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Chapter 1

Introduction

This work will on behalf of Arm investigate the performance of an existing phase locked loop (PLL) in a Narrow Band - Internet of Things (NB-IoT) transceiver with an integrated power amplifier (PA). Optimization of the PA is outside the scope of this work and focus will be on the PLL performance. The work has been carried out with Arm and in association with Lunds University, the department of Electrical and Information Technology at the faculty of engineering.

#### 1.1 Background

In the last decade, Internet of Things (IoT) and the demand for smart devices has grown massively and in June 2016 the specification for NB-IoT was completed. The use of PLLs in transceiver architectures has been widely examined and evaluated, but with new technologies comes new challenges. The demand from customers on NB-IoT developers is low power consumption, low maintenance, low cost and low complexity. Optimization of the transceiver can greatly reduce the power consumption and area and hence the cost, leading to a competitive edge. By integrating as much as possible on a single chip, the complexity as well as the cost can be greatly reduced giving a competitive edge.

## 1.2 Thesis objective

The goal with this work is to evaluate the feasibility of a fully integrated transceiver topology for NB-IoT from the PLL's perspective. The starting point of the work is an existing integrated  $\Delta\Sigma$  PLL with up-converter. A linear PA has already been constructed but no evaluation of the different impairments this PA has on the transceiver has been made. This work will aim to investigate to what extent this existing PLL can be used with the PA. The work will include:

2 Introduction

- The 3GPP specifications for NB-IoT will be studied and a mapping of the PLL requirement will be made in order to set the requirements for the PLL.
- A parameterisation of the performance of all blocks in the PLL will be made to ease the investigation of the overall performance.
- Investigation of the effects the integration of the PA has on the PLL.
- An implementation of the PLL for a fully integrated solution with integrated PA will be made.

#### 1.3 Thesis outline

The thesis outline is as follows;

Chapter 2, Theory: Presents the theory covered in this thesis.

Chapter 3, Narrow band internet of things phase noise requirements: Translates the 3GPP specifications for NB-IoT to phase noise requirement for the PLL.

Chapter 4, Parameterization PLL: This chapter presents how the PLL is parameterized.

Chapter 5, Pulling assessment: This chapter presents different balun and inductor designs and how to alter the PLL to reduce the effect of pulling as well as how to construct the inductor for best voltage controlled oscillator performance phase noise performance.

Chapter 6, Conclusion: Conclusion of the thesis and future work.

\_\_\_\_\_ Chapter 2

# Theory

In communication systems, a PLL is used in the transceiver to generate a programmable frequency. This frequency is a rational multiple of a reference frequency generated by a crystal oscillator (XO).

A PLL can be described as a control system that fixes the phase of the output to a relation of the input phase [9]. A PLL will maintain lock over the hold in range; for a charge pump phase detector PLL given by [5]:

$$\pm \Omega_H = \pm \omega_0 * \pi, \tag{2.1}$$

where  $\omega_0$  is the loop velocity constant and is defined as:

$$\omega_0 \triangleq \lim_{s \to 0} s * G(s) \tag{2.2}$$

G(s) is the forward transfer function times the feedback transfer function in Laplace domain. A flowchart describing a charge pump based fractional-N PLL is presented in figure 2.1. This is the PLL topology in focus throughout this work.

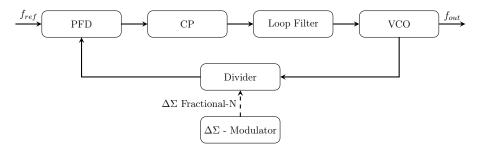


Figure 2.1: Flowchart presenting the blocks constituting the PLL

#### 2.1 Thermal noise

The thermal noise from a passive component can be expressed as

$$\overline{v^2} = 4 * k * T * R * \Delta f \tag{2.3}$$

$$\overline{i^2} = 4 * k * T * \frac{1}{R} * \Delta f \tag{2.4}$$

where k is Boltzmann's constant, T is the temperature in Kelvin and R is the resistance of the component generating the noise. The noise is an RMS noise and can be expressed as an RMS noise voltage (2.3) or as an RMS noise current (2.4). The thermal noise due to reactive components is due to its real part, this real part is small for the capacitors and will not contribute to the overall noise performance and will be omitted in this work [17]. However, the inductors might have a low Q and hence have a relative high real part. This real part has to be considered when calculating the thermal noise. If the thermal noise is represented as a voltage, it can be modeled as an ideal resistor in series with a voltage source equal to (2.3). If it is modeled as a current it can be represented as an ideal resistor in parallel with a current source equal to (2.4).

#### 2.2 Phase noise

Phase noise is a noise performance measure in the frequency domain. The IEEE definition of phase noise is:

$$\mathcal{L} \triangleq \frac{S_{\varphi}}{2},\tag{2.5}$$

where  $S_{\varphi}$  is the phase power spectral density.

To measure phase noise, one looks at the integrated power over one Hz related to the carrier at a certain frequency offset. Deviation in time from the true periodicity of a signal is called jitter. When examining the jitter in the frequency domain, it will appear as a frequency offset. Phase is the integral of frequency, hence jitter causes phase noise.

## 2.3 Phase frequency detector

When the PLL is locked, the phase frequency detector (PFD) acts as a phase detector (PD). The PD together with the charge pump (CP) is to deliver a current proportional to the phase error to the loop filter.

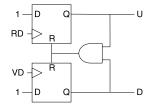


Figure 2.2: Phase detector

## 2.4 Charge pump

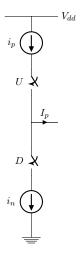


Figure 2.3: Charpe pump concept

The gain of the CP together with the PFD is given by the current delivered from the CP over one cycle of operation, hence:

$$K_{cp} = \frac{I_{cp}}{2\pi} \tag{2.6}$$

It is important that the current  $i_n=i_p$  in order to ensure the same gain for both negative and positive phase error. If this is not satisfied, negative and positive phase error will generate different  $K_{cp}$  and the transfer function off the PLL will deviate from the intended.

Net up and down currents have to be zero in order to minimize frequency spikes

#### 2.5 Loop filter

The transfer function of the PLL will mostly be determined by the characteristics of the loop filter. Extra poles and zeros can be introduced which will set the transient behavior of the PLL. By inserting an extra integrator in the loop,  $\omega_0$  becomes infinite (equation 2.2), hence the theoretical hold in range becomes infinite (equation 2.1). Introducing another pole at DC will cause instability and as a consequence an extra zero  $(\omega_z)$  has to be inserted in order to ensure stability. More poles  $(\omega_p)$  can be placed after the unity gain frequency  $(\omega_L)$  without causing instability in order to suppress high frequency noise. To achieve maximum stability,  $\omega_L$  should be placed at the geometrical mean of  $\omega_z$  and  $\omega_p$ ;  $\frac{\omega_L}{\omega_z} = \frac{\omega_p}{\omega_L}$ . Doing this also gives a good compromise between suppression of VCO noise, response speed, phase margin and rejection of side bands [5]. In figure 2.4, a third-order passive filter is presented.

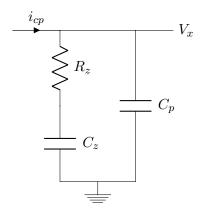
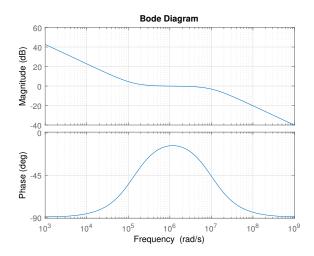


Figure 2.4: Passive third-order filter; integrator plus lead-lag

The transfer function for the filter in figure 2.4 from  $i_{cp}$  to  $V_x$  is given by:

$$G_x = \frac{s * (C_z + C_p)}{s^2 * R_z * C_z * C_p + s * (C_z * C_p)}$$
(2.7)

The bode plot for this filter is shown in figure 2.5.



**Figure 2.5:** Bode plot of the third-order filter

Using a passive filter as in figure 2.4 is advantageous in the sense that it is easy to design, however there are some drawbacks. As discussed in section "Charge pump", the operation voltage for the CP is limited. Due to varying temperature, the frequency tuning characteristics of the VCO might change. Also the voltage  $V_x$ , from figure 2.4 will change with temperature, and as a consequence of the change frequency tuning of the VCO. This change in  $V_x$  might lead to a mismatch in the CP's Up and Down currents, hence changing  $K_{cp}$  and altering the transfer function for the PLL. Also the threshold voltage  $(V_t)$  of the transistors in the CP are temperature and process dependent. A combination of all this might lead to that the operation voltage for the CP is drifting out of the well defined operation region. In order to solve this, an active filter can be used where a reference voltage is set in order to assure an operation well inside the well defined operation region for the CP [4]. It should be mentioned that it is possible to compensate for this voltage drift in digital domain by compensating for the changed frequency tuning characteristics. Another drawback with using a passive filter is the finite input impedance.

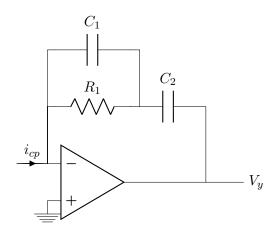


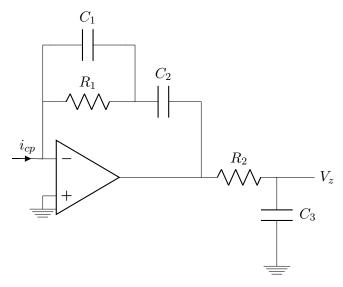
Figure 2.6: Active filter; integrator plus lead-lag

The transfer function for the filter in figure 2.6 from  $i_{cp}$  to  $V_x$  is given by:

$$G_y = \frac{1 + s * R_1 * (C_1 + C_2)}{s * C_2 * (1 + s * C_1 * R_1)} = \frac{1}{C_1} * \frac{1 + \frac{s}{\omega_z}}{s * (1 + \frac{s}{\omega_p})},$$
 (2.8)

where  $\omega_z = \frac{1}{R_1*(C_1+C_2)}$  is a zero and  $\omega_p = \frac{1}{R_1*C_2}$  is a pole. The bode plot for this filter will be identical to its passive counterpart and is shown in figure 2.5.

In order to further suppress high frequency noise, a forth-order filter as in figure 2.7 can be utilized. However the low-pass filter constituting of  $R_2$  and  $C_3$  will increase the low frequency thermal noise.



**Figure 2.7:** Active filter; integrator plus lead-lag with added low pass filter

By comparing figure 2.6 and 2.7, it can be noted that the transfer function for  $V_z$  will be given by  $V_x$  times the transfer function for a low pass filter comprised of  $R_2$  and  $C_3$ .

$$G_z = G_y * \frac{1}{1 + s * R_2 * C_3} \tag{2.9}$$

The bode plot for this filter is shown in figure 2.8.

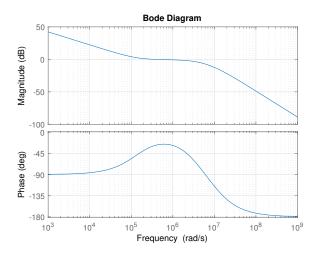


Figure 2.8: Bode plot of the forth-order active filter

#### 2.6 Voltage controlled oscillator

Oscillators consisting of an uneven number of inverters in a feedback system as shown in figure 2.9c are called Ring oscillators. They are easy to implement but have phase noise that is generally to high to consider them as a viable solution in communication systems [4]. The Q is typically low for these oscillators, and due to the switching nature of the ring oscillator, the noise is further increased [5]. Due to theses aspects, ring oscillators will not be considered here. In order to achieve a sufficient phase noise and Q for an integrated oscillator, an LC-oscillator topology can be used (shown in figure 2.9a and 2.9b). Q and the operational frequency will be determined by the LC-tank, where the frequency is determined by equation 2.10 and the unloaded Q is given by the inverse of equation 2.11.

$$f_0 = \frac{1}{2\pi\sqrt{LC}}\tag{2.10}$$

$$\frac{1}{Q_{tank}} = \frac{1}{Q_{ind}} + \frac{1}{Q_{cap}} \tag{2.11}$$

In order to achieve full voltage swing from ground to  $V_{dd}$  a complementary topology (as in figure 2.9b) can be utilized in contrast to the only NMOS tolopogy (figure 2.9a) where the full voltage swing is  $2 * V_{dd}$ . Utilizing a complementary topology provides a robust operation voltage for thin oxide transistors, this is beneficial as the process variation is lower in thin oxide transistors compared to thick oxide [8], the transconductance is higher and there is less parasitic capacitance. By matching the transconductance of the NMOS and PMOS, phase noise up conversion can be lowered. This is due to that injected current in the output node will be canceled, also disturbance will generate equal current in the transistors and hence the negative effect will be minimized [20].

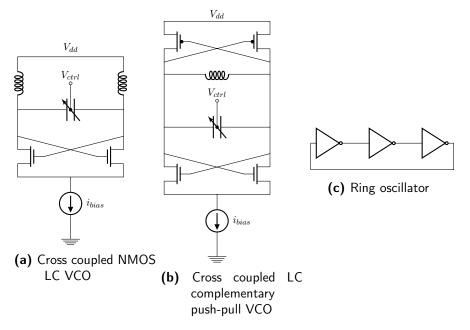


Figure 2.9: VCO

By using a varactor and applying a voltage  $(V_{ctrl})$  to it, it is possible to alter the frequency of the VCO. In a PLL, this frequency change will correspond to the gain of the VCO, which is denoted  $K_{VCO}$  and is given by the tangent of the tuning characteristics of the VCO in Hz/volt. By inspecting figure 2.1 one can see that the VCO is the last block in the PLL, this implies that noise generated by preceding blocks will be multiplied by the transfer function of the VCO. In a transceiver, all frequency bands for the intended purpose have to be covered and hence the tuning range has to cover all frequency bands. In figure 2.10 the dashed line illustrates a varactor used to cover all bands, the gain of the VCO will be as high as the slope of the tuning range. In order to lower the gain of the VCO, capacitance can be switched in depending on the frequency band in operation and a smaller varactor can be used (illustrated by the solid lines in figure 2.10). Furthermore, the linearity of a CMOS varactor is limited, hence having a large coverage of the

varactor will likely jeopardize linearity of the tuning characteristics.

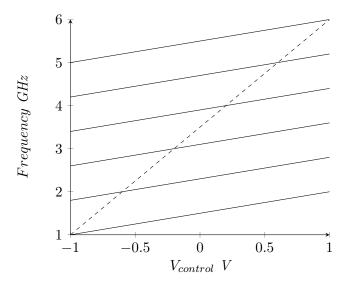


Figure 2.10: Illustration of tuning characteristics of a VCO

#### 2.6.1 VCO phase noise

The phase noise of a VCO is given by Leeson equation:

$$\mathcal{L}(\omega_m) = 10 * log \left( \frac{2 * F * k * T}{P_{sig}} * \left( 1 + \left( \frac{\omega_0}{2 * Q * \Delta \omega} \right)^2 \right) * \left( 1 + \frac{\Delta \omega_{1/f^3}}{|\Delta \omega|} \right) \right), (2.12)$$

where, F is the noise factor of the VCO viewed as an amplifier, Q is the loaded Q,  $P_{sig}$  is the output power of the signal,  $\omega_0$  is the carrier frequency,  $\Delta\omega$  is the frequency offset from the carrier frequency, T is temperature in Kelvin and k is Boltzmann's constant. From this equation it is possible to deduce that the roll off close to the carrier is  $1/\omega^3$  up to the corner frequency of the device, and  $1/\omega^2$  up to  $\omega_0/2Q$  where the noise flattens out to a constant value of  $10\log(\frac{2FkT}{P_{sig}})$ . It should be noted that measurements have shown that these frequencies can deviate from these values [9].

As  $Q_{ind}$  is generally much lower than  $Q_{cap}$  for frequencies below 5 GHz,  $Q_{tank}$  will mostly be determined by  $Q_{ind}$  (equation 2.11). Based on this assumption and further assuming a constant  $Q_{ind}$  regardless of inductor size and constant current bias, an analysis regarding phase noise as a function of inductor size can be made. The voltage swing in the VCO will be

$$V_{VCO} = I_{bias} * R_p, (2.13)$$

where  $R_p$  is the equivalent parallel resistance in the tank. Based on the assumption that  $Q_{ind}$  will determine  $Q_{tank}$  implies that

$$Q_{tank} = Q_{ind} = \frac{R_p}{\omega_0 * L} \tag{2.14}$$

The power of the signal is

$$P_{sig} = \frac{V^2}{R_p} = \frac{(I_{bias} * R_p)^2}{R_p} \propto R_p,$$
 (2.15)

based on the assumption that  $I_{bias}$  is constant. From equation 2.12 and 2.15 it is apparent that;

$$\mathcal{L}(\omega_m) \propto \frac{1}{P_{sig}} \propto \frac{1}{R_p} = \frac{1}{Q * \omega_0 * L},$$
 (2.16)

hence  $\mathcal{L}(\omega_m) \propto \frac{1}{L}$ . When the inductance is made so large that  $V_{VCO}$  no longer increases  $(V_{VCO} = V_{dd})$  in a complementary VCO topology), equation 2.15 becomes;

$$P_{sig} \propto \frac{1}{R_p} \Rightarrow \mathcal{L}(\omega_m) \propto \frac{1}{P_{sig}} \propto R_p \propto L$$
 (2.17)

From this analysis it can be concluded that increasing the size of the inductor will improve the phase noise performance of the VCO until the point where the voltage swing is no longer increased and then the phase noise performance will start to degrade.

#### 2.6.2 Frequency pulling VCO

Interfering frequencies on the VCO may lead to sidebands appearing on each side of the VCO output due to frequency pulling of the VCO [5]. Based on the findings in [22], these sidebands will be visible at the frequencies  $\omega_0 \pm (\omega_i - \omega_0)$  when the interfering frequency ( $\omega_i$ ) is far from the VCO frequency ( $\omega_0$ ). When the interfering frequency is closer to the VCO frequency and the power of the interferer is sufficiently high the VCO will be in a so called "quasi lock". The first side bands will appear at  $\omega' \pm \Omega$  and the other side bands will appear asymmetrical around the VCO frequency. To increase the readability, table 2.1 will serve as a conspectus of the variables describing the pulling effects.

Variable	Description
$\omega_0$	Free running VCO frequency
$\omega_i$	Interfering frequency
$\Delta\omega_0$	$\omega_0-\omega_i$
$\omega_L$	Lock range = $\frac{\omega_0}{2Q} \frac{E_i}{E_{osc}}$
$\omega'$	$\omega_0 + \frac{a^2}{2}\Delta\omega_0$
a	$rac{\omega_L^-}{\Delta\omega_0}$
$A_0$	Amplitude of the VCO
$\Omega$	$\Delta\omega_0 - \alpha(t)$
$\alpha(t)$	$rac{a^2}{2\Delta\omega_0}$

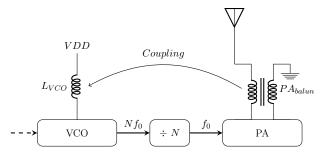
**Table 2.1:** Description of the variables used to describe the frequency pulling effect of the VCO.

The maximum amplitude when in "quasi lock" will be  $A_0*(1-\frac{a^2}{4})$  for the VCO frequency,  $\frac{A_0a}{2}*(1+\frac{a^2}{4})$  for the sideband at frequency  $\omega'+\Omega$  and  $\frac{A_0a}{2}$  for the sideband at  $\omega'-\Omega$ . When the interferer is well outside the frequency locking range, there will be two sidebands with the relative amplitude of [15]:

Relative sideband amplitude = 
$$\frac{1}{2} * \frac{\omega_L}{\Delta \omega_0}$$
, (2.18)

## 2.7 Frequency pulling PLL

Figure 2.11 illustrates the origin of frequency pulling considered in this thesis for a fully integrated transceiver. N will be 2, 4 or 8 depending on which frequency band to transmit on. When N is 2, the second order harmonic of the PA is approximately the same frequency as the VCO frequency. This second order harmonic, through the coupling from the PA balun to the VCO inductor will cause frequency pulling. As the pulling is caused by the PA, through the balun; the balun is called aggressor and the inductor is called victim.



**Figure 2.11:** Flowchart illustrating the source of frequency pulling in a fully integrated transceiver.

In [19] an analysis of frequency pulling of a PLL with a first order filter is made. It is stated here that if the difference between the pulling frequency and the operating frequency of the VCO is inside the range of the PLL bandwidth, the effect of pulling is suppressed.

In [13] and [3] an analysis of the effects of pulling of the VCO in a PLL is made for a transmitter. The equation describing the phase deviation from the original due to frequency pulling is given by

$$\Theta(j\omega) = \frac{\omega_0 * I_2(j\omega)}{2 * Q * I_s * (j\omega + \frac{K_{VCO}}{N} * \frac{I_{CP}}{2*\pi} * H_{filter}(j\omega))}$$
(2.19)

where Q is the Q of the LC tank in the VCO,  $\omega_0$  is the operating frequency of the VCO,  $I_s$  is the bias current of the VCO, N is the divide ratio of the divider in the feedback of the PLL,  $H_{filter}$  is the transfer function of the PLL filter and  $I_2(j\omega)$  is the Fourier transform of the current of the second order harmonic from the power amplifier (PA) with a modulated signal (equation 2.20).

$$k * i_2 * A_{BB}^2(t) * sin(2 * \theta_{BB}(t)) \xrightarrow{\mathcal{F}} I_2(j\omega)$$
 (2.20)

where, k is the coupling from the PA to the VCO,  $i_2$  is the current of the second order harmonic from the PA,  $A_{BB}(t)$  is the amplitude of the baseband modulation and  $\theta_{BB}(t)$  is the phase of the baseband modulation.

#### 2.8 Fractional-N PLL

In order to implement a feasible PLL for NB-IoT the frequency accuracy has to be higher than the spacing between the channels. Utilizing only the divider in the feedback of the PLL architecture results in a fixed integer division ratio. This implies that only an integer of the reference frequency can be generated by the PLL, hence the reference frequency has to be as low as the channel spacing. A low reference frequency leads to a limited loop bandwidth and according to [4] the loop bandwidth can be maximum a tenth of the reference frequency in order to assure linear operation of the phase detector. Also, a low reference frequency leads to a high N multiplying the noise of the reference frequency, the loop filter and the phase frequency detector with a larger number.

By letting the divider alter between N+1 and N the PLL can lock to the average of the two, making the output frequency an integer plus a fraction where the fraction will set the resolution of the output frequency and hence mitigating the need of a low reference frequency. It is from this fraction the architecture got its name  $Fractional-N\ PLL$ .

The technique presented above introduces spurs due to the multiplying pattern when generating the fraction, and reference sub-harmonics corresponding to the least common divisor of the fractional frequency and the reference frequency is to

be expected [5]. The problem with this architecture is intensified when the fraction is close to 0 or 1 as the frequency of the switching between N and N+1 is low and will introduce low frequency noise which cannot be filtered by the PLL. To reduce this problem a  $\Delta\Sigma$  modulator (DSM) can be used.

#### 2.8.1 Delta sigma modulator

A DSM has noise-shaping properties and shifts the frequency from DC to higher frequencies for all multiples of the reference frequency. However, this noise shaping properties are not valid for first order DSM with DC-inputs, and hence a higher order DSM should be used [23] [21]. This high frequency noise will be filtered by the loop filter and it should be noted that a higher PLL bandwidth reduces the filtering of spurs from the DSM modulator.

16	Theory

\_\_\_\_\_ Chapter 3

# Narrow band internet of things phase noise requirements

#### 3.1 Receiver requirement

#### 3.1.1 Selectivity

Signals close to the frequency band of the desired signal, called blockers, might affect the performance of the receiver. These out-of-band blockers in combination with the phase noise of the PLL can lead to down conversion of the blocker to the intermediate frequency (IF) of the receiver, called reciprocal mixing. This happens if the blocker and the phase noise of the PLL are at the same offset as the desired signal is to the center frequency of the PLL. The maximum phase noise in order to achieve a selectivity of a given value is determined by:

$$\mathcal{L}(f_m) = C - S - I - 10\log(B), [dBc/Hz], \tag{3.1}$$

where  $\mathcal{L}(f_m)$  is the phase noise at the offset frequency  $f_m$ , C is the desired signal in dBm, S is the selectivity in dB, I is the interfering signal in dBm and B is the bandwidth of the Intermediate frequency filter in Hz [18]. One could argue that equation 3.1 overestimates the required phase noise performance of the PLL, as mixing of the desired signal with the blocker will be spread out over the frequency spectra of the frequency from the desired signal to the frequency of the blocker (figure 3.1). To account for this, the phase noise can be integrated over the frequency spectra. From equation 2.12 the noise figure can be estimated as a  $1/f^2$  roll-off from the VCO, leading to equation 3.2.



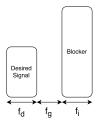


Figure 3.1: Interfering signal

$$K = \frac{1}{f_i * f_d} * \int_0^{f_i} \int_{f+f_g}^{f+f_g+f_d} \left(\frac{f_g}{f}\right)^2 df df = \frac{f_g^2}{f_i * f_d} * \left(ln\left(\frac{f_i + f_g}{f_i + f_g + f_d}\right) - ln\left(\frac{f_g}{f_g + f_d}\right)\right), \tag{3.2}$$

where  $f_d$  is the bandwidth of the desired signal,  $f_g$  is the frequency difference between desired and interfering signal and  $f_i$  is the bandwidth of the interfering signal (figure 3.1). Notice the factor  $(f_g/f)^2$  from equation 2.12,  $w_0$  is changed to  $f_g$  here as it is the phase noise at the frequency  $f_g$  we are weighting. Equation 3.1 can now be rewritten as:

$$\mathcal{L}(f_m) = C - S - I - 10log(B) - K, [dBc/Hz], \tag{3.3}$$

The specification for the receiver in NB-IoT constitutes of three requirements that will determine the phase noise of the PLL; Adjacent channel selectivity (ACS), In-band blocking and Out-of-band blocking. Some parameters are needed in order to perform the calculations.

- The Signal-to-noise ratio (SNR, corresponding to S in equation 3.1 and 3.3) is 0 dB (given from simulations previously made by ARM).
- The reference sensitivity (REFSENSE) is -108.2 dBm.

Table 7.5.1F: Adjacent channel selectivity parameters for category NB1 and NB2

ACS1 test Parame	ters	
Interferer	GSM (GMSK)	E-UTRA
Category NB1 or NB2 signal power (P <sub>wanted</sub> ) / dBm	REFSEN	S + 14 dB
Interferer signal power (P <sub>Interfere</sub> r) / dBm	REFSENS + 42 dB	REFSENS + 47 dB
Interferer bandwidth	200 kHz	5 MHz
Interferer offset from category NB1 or NB2 channel edge	±200 kHz	±2.5 MHz
ACS2 test Parame	ters	
Interferer	GSM (GMSK)	E-UTRA
Category NB1 or NB2 signal power (P <sub>wanted</sub> ) / dBm	-53 dBm	-58 dBm
Interferer signal power (P <sub>Interferer</sub> ) / dBm	-25	dBm
Interferer bandwidth	200 kHz	5 MHz
Interferer offset from category NB1 or NB2 channel edge	±200 kHz	±2.5 MHz

Figure 3.2: ACS from 3GPP specifications [1].

#### Narrow band internet of things phase noise requirements

Table 7.6.1.1F-1: In-band blocking parameters for category NB1 and NB2

IBB1 test Parameters	
Category NB1 or NB2 signal power (P <sub>wanled</sub> ) / dBm	REFSENS + 6 dB
Interferer	E-UTRA
Interferer signal power (P <sub>Interferer</sub> ) / dBm	- 56 dBm
Interferer bandwidth	5 MHz
Interferer offset from category NB1 or NB2 channel edge	+7.5 MHz + 0.005 MHz and -7.5 MHz - 0.005 MHz
IBB2 test Parameters	
Category NB1 or NB2 signal power (P <sub>wanled</sub> ) / dBm	REFSENS + 6 dB
Interferer	E-UTRA
Interferer signal power (Pinterferer) / dBm	- 44 dBm
Interferer bandwidth	5 MHz
Interferer offset range from category NB1 or NB2 channel edge	From +12.5 MHz to F <sub>DL_high</sub> + 15 MHz and From -12.5 MHz to F <sub>DL_low</sub> - 15 MHz

Figure 3.3: In-band-blocking from 3GPP specifications [1].

Table 7.6.2.1F-1: Out-of-band blocking parameters for category NB1 and NB2 UE

		11.00		Frequency	
Parame	eter	Units	Range 1	Range 2	Range 3
Punt	•d	dBm	000000000000000000000000000000000000000	REFSENS + 6 dB	
Printer	(CW)	dBm	-44	-30	-15
<b>2</b> 8	2225	MHz	Fralow - 15 to Frat_low - 60	For_low - 80 to For_low - 85	Foc_low - 85 to 1 MHz
Fineferer	ange	MHz	Follow + 15 to Follow + 60	Follow 60 to Follow + 85	FpL_high + 85 to 12750 MHz
NOTE 2:	and Fr	ol_high + 1	<sub>wot</sub> - 150 MHz of the lowest ba 50 MHz of the highest band tha ands which downlink band frequ	nd that UE supports in frequency t UE supports in frequency rang	e 729 MHz < f < 1 GHz.
NOTE 2:	and Fr For op power which f < 22 1475.9 For op level of bound	bi_light+1 berating bi level of this bound 00 MHz at MHz < the materials berating bi the interled by Fo	50 MHz of the highest band tha	nd that UE supports in frequency to UE supports in frequency range is between 1475.9 is 3 shall be modified to: 20 dBn west band that UE supports in fighest band that UE supports supports to the supports of the support of the supports of the support of the supports of the support of the support of the supports of the support of	y rangé 228 MHz < f < 1 GHz e 729 MHz < f < 1 GHz MHz < f < 2200 MHz the n for the frequency range requency range 1475.9 MHz < sports in frequency range Hz < f < 467.5 MHz the power he frequency range which is

Figure 3.4: Out-of-band blocking from 3GPP specifications [1].

Inserting the parameters from figure 3.2, 3.3 and 3.4 in equation 3.2 and 3.3 results in the values presented in table 3.1. The bandwidth (interferer bandwidth) given in the 3GPP specification has been scaled with 0.9\*bandwidth as LTE utilizes 10 % of the bandwidth as guard bands.

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Requirement	Blocker	Frequency offset KHz	$\mathcal{L}(f_m)$ $dBc/Hz$
ACS1	GSM	110	-75.4
	E-UTRA	250	-83.6
ACS2	GSM	110	-73.2
	E-UTRA	250	-71.5
IBB1	E-UTRA	5255	-96.0
IBB2	E-UTRA	10250	-109
Out-of-band blocking	Range 1	15000	-110.8
	Range 2	60000	-124.8
	Range 3	85000	-139.8
	NOTE 1	15000	-136.8
	NOTE 2	20000	-134.8
	NOTE 3	15000	-136.8

**Table 3.1:** Phase noise requirements due to blockers, calculated using equation 3.3 and values from figure 3.4.

### 3.2 Transmitter requirement

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#### 3.2.1 Adjacent Channel Leakage Ratio

Table 6.6.2F.3-1: category NB1 and NB2 UE ACLR requirements

	GSMACLE	UTRAAGLE
ACLR	20 dB	37 dB
Adjacent channel center frequency offset from category NB1 or NB2 Channel edge	±200 kHz	±2.5 MHz
Adjacent channel measurement bandwidth	180 kHz	3.84 MHz
Measurement filter	Rectangular	RRC-filter a=0,22
Category NB1 and NB2 channel measurement bandwidth	180 kHz	180 kHz
Category NB1 and NB2 channel Measurement filter	Rectangular	Rectangula

Figure 3.5: ACLR requirement from 3GPP [1].

$$\mathcal{L}(f_m) = ACLR - 10log(B_{ACLR}) - K, \tag{3.4}$$

where ACLR is the maximum power and  $B_{ACLR}$  is the adjacent channel measurement bandwidth given in figure 3.5 and K is calculated using equation 3.2.

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#### 3.2.2 Spurious emission

		2-1: Req							E UTRA Barel 1 S. 7, 8, 22, 51, 32, 53, 33, 63, 65, 65, 67, 69 E UTRA Barel 23	Fig. po.		Pictor.	50		- 15
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and	Protected band	Freque	MHS	nange	Maximum Level	(MHz)	NOIE	- 21	Fritgacke (2003) F L/TRA Box (1.18, 16, 28, 16, 42, 46		1	796	-60	- 4	-
		-			(dBm)		_	538	Frequency range	M:		F <sub>30,789</sub>	+50	100	_
	E-JITTA Cares (5.7 ft, 1), 10, 10, 20, 21, 22, 26 cf, 22, 31 ft, 38, 40, 41, 42, 40, 44 d5 65, 67, 68 d9 E-JITTA David 3, 34	*x.m.		Poulse	-99	1			Fing warp range	33-1 33-1		1379.9	-63	0.2	
	F. (FPA David 3.34	3/3/11	-	Famo	-00	-	15		Frequency range Frequency range	3545	-	1915.7	-40	0.2	-
	Processing range	76. m 1880	-	1605	-40	i	2.27	- 22	Frequency range E-UTHA Base 1 S. F. B. 20, 26, 27, 28 2 D2, 30, 24, 35, 30, 40, 40, 65, 67, 63, 63	2501	4	2545	-50		
	Proceercy range	1505		1915	-15.2	5	5, 26, 27	- 22	2 .02, 30, 24, 35, 92, 40, 43, 25, 67, 63,	See	4	Francis	+50		
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		* A. m.	-	Γ <sub>0, reps</sub>	+20	1	- 11	100	35, 27, 26, 59, 30, 41, 42, 46, 65, 70	100	3	Fourter	+50		ш
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	Frequency range	946		160	51	15			Everancy rarge	3315		5655	- 00		
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								168	5-073A David 45-40 5-073A Ryad 9, 7, 8-20, 59, 34, 34, 34	Fare		False	-62		
									40, 42, 43, 47, 68	Source		Facep	60	- 53	
								1	F-IITRA Rand 1	Philips		Fried	50	-	- 8
								- 70	F UTRA Solid 2, 4, 6, 10, 12, 12, 14, 17, 24, 55, 56, 56, 56, 56, 41, 46, 66, 70	Sinne	-	Faye	60	100	
									I be on the second of the second						

**Figure 3.6:** 3GPP specifications for spurious emission, band 1, 2, 3, 5, 8, 11, 12, 13, 17, 18, 19, 20, 21, 25, 26, 28, 31, 66 and 70 are included in NB-IoT [1].

$$\mathcal{L}(f_m) = Maximum \ Level - P_{out} - 10 * log(MBW), \tag{3.5}$$

where  $P_{out}$  is the maximum output power from the transmitter as this will set the worst case, Maximum level and the measurement bandwidth (MBW) are given in figure 3.6.

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#### 3.2.3 Out of band emissions

Table 6.6.2F.1-1: category NB1 and NB2 UE spectrum emission mask

Δf <sub>OOB</sub> (kHz)	Emission limit (dBm)	Measurement bandwidth
± 0	26	30 kHz
±100	-5	30 kHz
± 150	-8	30 kHz
±300	-29	30 kHz
±500-1700	-35	30 kHz

Figure 3.7: Out of band emission specifications from 3GPP [1].

$$\mathcal{L}(f_m) = Emission\ limit - P_{out} - 10 * log(MBW), \tag{3.6}$$

where  $P_{out}$  is the maximum output power from the transmitter as this will set the worst case, emission limit and MBW are given in figure 3.7.

#### 3.2.3.1 In-band emissions

Table 6.5.2F.3-1: Minimum requirements for in-band emissions

descrip	eter tion	Unit		Limit (NOTE 1)	Applicable Frequencies	
Gener	ral	dB	-18	$[-15-10 \cdot \log_{10}(N_{how}/L_{Chow}),$ $-5 \cdot ( \Delta_{how} -1)/L_{Chow},$ $dBm \cdot (3.75 kHz \cdot or 15 kHz) - P_{how}$	Any non-allocated (NOTE 2)	
IQ Ima	ige	dB		-25	Image frequencies (NOTES 2, 3)	
Carrie	ar	55/504414	-25	0 dBm ≤ Output power	Carrier frequency	
leaka			-20 -10	-30 dBm ≤ Output power ≤ 0 dBm -40 dBm ≤ Output power < -30 dBm	(NOTES 4, 5)	
NOTE 3:	allocated to allocated to The application	one to the meas ones. able frequencies	ured average p of or this limit a	d the limit is expressed as a ratio of measi lower per allocated tone, where the average re those that are enclosed in the reflection act to the centre carrier frequency, but excl	jing is done across all of the allocated	
NOTE 4:	allocated to allocated to The applications. The measurable allocated to The applications.	one to the meas ones. able frequencies , based on symn urement bandwic one to the meas able frequencies	ured average p s for this limit au netry with respo ith is 1 tone an ured total powe s for this limit au	ower per allocated tone, where the average to those that are enclosed in the reflection act to the centre carrier frequency, but exci- d the limit is expressed as a ratio of measi er in all allocated tones.	ing is done across all of the allocated uding any allocated ured power in one non taining the DC	
NOTE 4:	allocated to allocated to The application bandwidth tones. The measurable allocated to The application frequency	one to the meas ones. able frequencies , based on symn urement bandwic one to the meas able frequencies	ured average p for this limit au netry with respo th is 1 tone an ured total powe for this limit au or in the two to	ower per allocated tone, where the average those that are enclosed in the reflection act to the centre carrier frequency, but exclid of the limit is expressed as a ratio of measi or in all allocated tones.	ing is done across all of the allocated uding any allocated ured power in one non taining the DC	
NOTE 4: NOTE 5:	allocated to allocated to The application bandwidth tones. The measurable allocated to The application frequency but excluding	one to the meas ones: able frequencies , based on symm urement bandwid one to the meas able frequencies if N <sub>ierce</sub> is odd,	ured average p for this limit au netry with respo th is 1 tone an ured total powe for this limit au or in the two to it tone.	ower per allocated tone, where the average te those that are enclosed in the reflection sect to the centre carrier frequency, but exclid difficial to the second of the limit is expressed as a ratio of measuring in all allocated tones, to those that are enclosed in the tones con nes immediately adjacent to the DC frequence.	ing is done across all of the allocated uding any allocated ured power in one non taining the DC	
NOTE 4: NOTE 5:	allocated to allocated to the applic bandwidth tones. The meast allocated to the applic frequency but exclud $L_{\rm Clause}$ is the applic but excluded the application of the applicati	one to the meas ones, able frequencies, based on symmurement bandwice one to the meas able frequencies if $N_{\rm lowe}$ is odd, ing any allocated the Transmission	ured average p s for this limit au netry with respo sith is 1 tone an ured total power for this limit au or in the two to st tone. Bandwidth (to	ower per allocated tone, where the average te those that are enclosed in the reflection sect to the centre carrier frequency, but exclid difficial to the second of the limit is expressed as a ratio of measuring in all allocated tones, to those that are enclosed in the tones con nes immediately adjacent to the DC frequence.	ing is done across all of the allocated uding any allocated ured power in one non taining the DC	
NOTE 4: NOTE 5: NOTE 6: NOTE 7:	allocated to allocated to the application of the measurable of the application of the ap	one to the meas ones.  able frequencies, based on symmurement bandwire one to the meas able frequencies if $N_{\rm some}$ is odd, ing any allocate the Transmission one Transmission.	ured average p for this limit at netry with respe th is 1 tone an ured total powe for this limit at or in the two to it tone. Bandwidth (to Bandwidth Co	ower per allocated tone, where the average te those that are enclosed in the reflection sect to the centre carrier frequency, but excluding the limit is expressed as a ratio of measuring in all allocated tones. The those that are enclosed in the tones con nes immediately adjacent to the DC frequences).	ing is done across all of the allocated using any allocated using any allocated ured power in one non taining the DC ency if $N_{\rm tone}$ is even.	
NOTE 4: NOTE 5: NOTE 6: NOTE 7:	allocated to allocated to the application of the measurable of the application of the ap	one to the meas ones, able frequencies, based on symmurement bandwike one to the meas able frequencies if $N_{\rm some}$ is odd, ing any allocated the Transmission he Starting frequencies starting frequencies.	ured average p s for this limit an netry with respe- sith is 1 tone an ured total power or in the two to it tone. I Bandwidth (to Bandwidth Co- ency offset bets	ower per allocated tone, where the average te those that are enclosed in the reflection act to the centre carrier frequency, but excluding the limit is expressed as a ratio of measuring in all allocated tones. The those that are enclosed in the tones con nes immediately adjacent to the DC frequency.	ing is done across all of the allocated using any allocated using any allocated ured power in one non taining the DC ency if $N_{\rm lone}$ , is even non-allocated tone,	

Figure 3.8: In-band emission specifications from 3GPP [1].

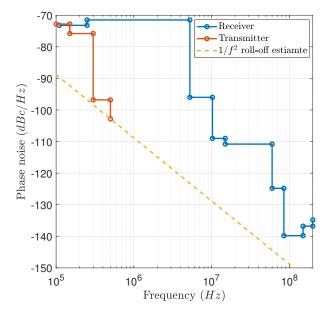
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### 3.2.4 Transmitter requirement summary

C:C+:	D 1	D	C(f ) 1D - /II
Specifications	Band	Frequency offset KHz	$\mathcal{L}(f_m) \frac{dBc/Hz}{25.9}$
ACLR - GSM	N/E	110	-25.2
ACLR - UTRA	N/E	580	-26.8
Spurious emission	1	30000	-133
	2	30000	-133
	3	20000	-133
	5	10000	-110
		20000	-133
	8	10000	-133
	11	28000	-133
	12	18000	-133
	13	2000	-96
		21000	-133
	17	18000	-133
	18	12000	-123
		16000	-133
	19	27000	-133
	20	44000	-133
	21	37700	-133
	25	15000	-133
	26	10000	-133
	28	9000	-117
		10000	-115
		25000	-133
	31	5000	-133
		12500	-134
	66	150000	-133
	70	136000	-133
Out of band emissions	N/E	0	-41.8
	m N/E	100	-72.8
	m N/E	150	-75.8
	N/E	300	-96.8
	m N/E	500 - 1700	-102.8
In-band emissions	N/E	0	-30

**Table 3.2:** Summary of phase noise requirement for transmitter concluded from figure 3.5, 3.6, 3.7 and 3.8 using equation 3.4, 3.5 and 3.6.

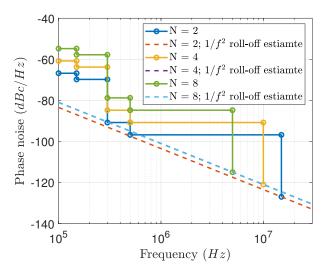
Figure 3.9 presents the non-normalized phase noise requirement from table 3.1 and 3.2 excluding the band specific requirement for the transmitter.



**Figure 3.9:** Non-normalized Phase noise requirement NB-IoT for blocker and transmitter by interpolating values from table 3.1 and 3.2. The dotted line presents the worst case  $1/f^2$  roll-off estimate.

The operating frequency of the VCO is 2529.8 - 4538.1 MHz with a divider of two, four or eight depending on which band to be used. This divide ratio will reduce the noise requirement for the PLL corresponding to the divide ration, hence 6 dB for a divide ratio of two, 12 dB for a divide ratio of four and 18 dB for a divide ratio of eight. By altering the phase noise requirement correspondingly and by only including the bands from table 3.2 corresponding to the correct division ratio, an estimate for the phase noise of the PLL for each division ratio can be made (figure 3.10). As the requirement is stricter for the PLL when transmitting, focus will be on this scenario. From table 3.2, band 31 will set the requirement when the division ratio is eight, band 8 will set the requirement when the division ratio is 2.

#### Narrow band internet of things phase noise requirements



**Figure 3.10:** Phase noise requirement NB-IoT for the transmitter, normalized to division ratio. The dotted line presents the worst case  $1/f^2$  roll-off estimate.

#### 3.2.5 EVM

The error vector magnitude (EVM) is given by:

$$EVM = \sqrt{\frac{P_{error}}{P_{reference}}},$$
 (3.7)

where  $P_{error}$  is the average power in the error vector and  $P_{reference}$  is the average power in the ideal reference vector.

Presumed that the contributing factors to the total EVM are uncorrelated, the total EVM of the transmission signal can be written as:

$$EVM_{total} = \sqrt{\sum_{n=1}^{k} EVM_n^2},$$
(3.8)

where  $EVM_n$  denotes all the contributing sources. The contributing sources are due to imbalance in I and Q, nonlinearities, carrier leakage and phase noise [14]. The only parameter where the PLL performance is relevant in the degradation in the EVM is due to phase noise, hence focus will be on this parameter.

$$EVM_{rms} = \sqrt{\frac{1}{SNR} + 2 - 2 * e^{-\frac{\sigma^2}{2}}},$$
 (3.9)

where  $SNR = \frac{E_s}{E_0}$  for the PLL and  $\sigma$  is the RMS LO phase error [6]. In [10] it is given that the rms phase error is

$$\phi_{rms}^2 = 2 * \int_0^{inf} 10^{\frac{\mathcal{L}(f)}{10}} df \tag{3.10}$$

By combining equation 3.9 and 3.10 and plotting EVM against integrated phase noise for different SNR, an estimate of how much the EVM will be degraded can be made.

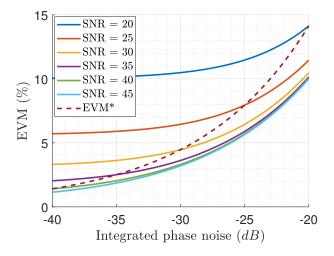
In [2] another formula for calculating EVM is given:

$$EVM_{\%} = 100 * \frac{\pi}{180} * \sigma_{\phi(deg)},$$
 (3.11)

where  $\sigma_{\phi(deg)}$  is given by equation 3.12.

$$\sigma_{\phi(deg)} = \frac{180}{\pi} * \sqrt{2 * \int_{x_2}^{x_1} 10^{\frac{\mathcal{L}(f)}{10}} df}, \qquad (3.12)$$

where  $x_2$  is set by how often the base station is sending out reference symbols and how the channel estimate is determined and  $x_1$  is the channel bandwidth. For this work,  $x_2$  will be set to 1 kHz and  $x_1$  to 90 kHz.



**Figure 3.11:** EVM as a function of integrated phase noise, where EVM\* denotes equation 3.11.

The total EVM<sub>rms</sub> for narrow band IoT is 17.5 %. However, the EVM degradation due to the PLL should be lower in order to relax the design of the PA where linearity can be traded for power efficiency. In consultation with Arm the allowed EVM contribution from the PLL was set to 5 % for the transmitter. When receiving,

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the modulation scheme is QPSK (four symbols) and hence the EVM requirement can be further relaxed to 10 %.

EVM <sub>%</sub>	$\text{EVM}_{dB}$
17.5	-15.1
10	-20.0
5	-26.0

**Table 3.3:** Table presenting recalculation of  ${\rm EVM}_{\%}$  to  ${\rm EVM}_{dB}$  single sideband.

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\_\_\_\_\_ Chapter 4

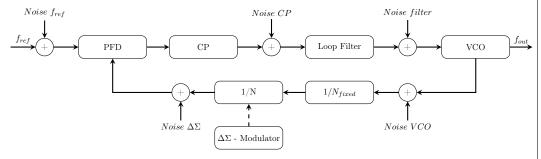
# Parameterization PLL

## 4.1 Starting point

From figure 3.10 and table 3.2 it can be concluded that the frequency band that limits the phase noise is when transmitting on band 25, as the criterion points indicated for a 500 kHz and 300 kHz offset is due to "Out of band emissions" requirement; hence the approach to optimize the PLL will be for this scenario. The center frequency for band 25 when transmitting is 1882.5 MHz, making  $f_{VCO} = 3765$  MHz (due to the divide by two after the VCO).

### 4.2 Noise calculation

In order to ease the redesign of the PLL, all noise sources where parameterized and inserted into a MatLab script where they were used to approximate the total noise performance of the PLL. To do this, the transfer function for each block had to be accounted for. From figure 4.1 the transfer function for each noise source can be derived.



**Figure 4.1:** Flowchart for calculating noise transfer function for all PLL blocks.

Parameterization PLL

$$H_{ol} = K_{PFD} * K_{CP} * K_{Loop\ Filter} * K_{VCO} * \frac{1}{N_{fixed}} * \frac{1}{N} = \frac{I_{cp} * K_{vco} * (s*R_1 * (C_1 + C_2) + 1)}{(s^2 * C_2 * N * N_{fixed} * (s*C_1 * R_1 + 1) * (s*C_3 * R_2 + 1)} \tag{4.1}$$

$$H_{fref} = \frac{K_{PFD}*K_{CP}*K_{Loop\ Filter}*K_{VCO}}{1+H_{ol}} = \frac{I_{cp}*K_{vco}*N*N_{fixed}*(s*R_1*(C_1+C_2)+1)}{(s^2*C_2*N*N_{fixed}*(s*C_1*R_1+1)*(s*C_3*R_2+1)+I_{cp}*Kvco*(s*R_1*(C_1+C_2)+1))} \tag{4.2}$$

$$H_{CP} = \frac{K_{CP}*K_{Loop\ Filter}*K_{VCO}}{1+H_{ol}} = \frac{2*\pi*I_{cp}*K_{vco}*N*N_{fixed}*(s*R_1*(C_1+C_2)+1)}{(s^2*C_2*N*N_{fixed}*(s*C_1*R_1+1)*(s*C_3*R_2+1)+I_{cp}*K_{vco}*(s*R_1*(C_1+C_2)+1))} \tag{4.3}$$

$$H_{Loop\ Filter} = \frac{K_{Loop\ Filter}*K_{VCO}}{1+H_{ol}} = \frac{2*\pi*K_{vco}*N*N_{fixed}*(s*R_1*(C_1+C_2)+1)}{s^2*C_2*N*N_{fixed}*(s*C_1*R_1+1)*(s*C_3*R_2+1)+I_{cp}*K_{vco*}(s*R_1*(C_1+C_2)+1)} \tag{4.4}$$

$$H_{vco} = \frac{K_{VCO}}{1+H_{ol}} = \frac{s*2*\pi*C_2*K_{vco}*N*N_{fixed}*(s*C_1*R_1+1)*(s*C_3*R_2+1)}{s^2*C_2*N*N_{fixed}*(s*C_1*R_1+1)*(s*C_3*R_2+1)+Icp*K_{vco}*(s*R_1*(C_1+C_2)+1)} \tag{4.5}$$

$$H_{\Delta\Sigma} = \frac{K_{PFD}*K_{CP}*K_{Loop\ Filter}*K_{VCO}}{1+H_{ol}} = \frac{I_{cp}*K_{vco}*N*N_{fixed}*(s*R_1*(C_1+C_2)+1)}{(s^2*C_2*N*N_{fixed}*(s*C_1*R_1+1)*(s*C_3*R_2+1)+I_{cp}*Kvco*(s*R_1*(C_1+C_2)+1))} \tag{4.6}$$

### 4.2.1 Charge pump

The output of the CP is a current going through a filter, hence the noise source of interest is the current noise. The noise contribution can be divided in to two parts, one part from the flicker noise in the transistors and the second part is due to the thermal noise. The thermal noise is given by equation 2.4, where R is the total resistance in the CP given by  $R = \frac{V_{ad}/2}{I_{Cp}}$ . This thermal noise has to be multiplied by two in order to account for the noise in both "UP" and "DOWN" operation.

The flicker noise of the transistor is given by:

$$\frac{i_{1/f}^2}{i_{1/f}^2} = K * \frac{I_D^a}{f} * \Delta f$$
(4.7)

where  $I_D$  is the drain bias current and K and a is process dependent fitting parameters [7]. In order to find the values of K and a, the current noise of the charge pump was simulated for different charge pump currents. The initial noise current for these curves (spot noise at 100 Hz) versus charge pump current where curve fitted as a power function using MatLab, resulting in K = 0.02442 and a = 4.018. By taking the sum of the thermal- and flicker- noise, the noise for different

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currents could be validated by comparing the calculated values with simulations (figure 4.2).

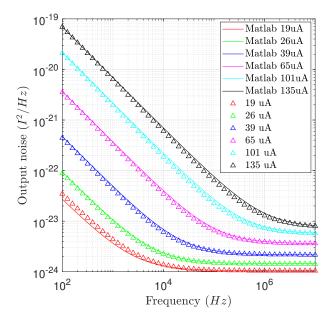
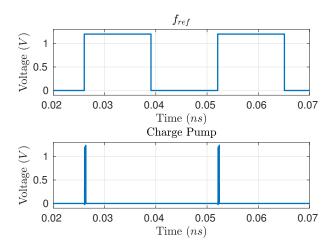


Figure 4.2: Output current noise from charge pump for different charge pump currents; "MatLab" is referring to equation 4.7 and  $\Delta$  is simulated noise using Spectre.

The total noise from the charge pump has to be related to its duty cycle. In order to correct for this, a simulation to measure the *on time* had to be made, this time was then divided by the period time of  $f_{ref}$  (figure 4.3).

$$\alpha_{cp} = \frac{t_{on}}{t_{f_{ref}}} \tag{4.8}$$



**Figure 4.3:** On time for CP in comparison to  $f_{ref}$  in order to calculate total noise.

The total noise from the CP is

$$\overline{i_{cp}^2} = \alpha_{cp} * (2 * 4 * k * T * \frac{1}{R} * \Delta f + K * \frac{I_D^a}{f} * \Delta f)$$
(4.9)

#### 4.2.2 Filter

The noise contribution due to the filter presented in figure 2.7 can be approximated by transforming all the noise sources to the input as an *equivalent input noise* source. This input noise source is then transformed through the transfer function of the filter in order to get the noise at the output [25].

As the output of the filter is connected as a control voltage to the VCO, the noise source of interest from the filter in the analysis of the PLL is the voltage noise. The noise introduced by the passive components is given by equation 2.3. The Op-amp in the filter is constructed by a differential pair and a common source amplifier. The Op-amp will also generate noise but due to the gain in the differential pair, the noise of the common source will be suppressed.

$$\overline{v_{Th}^2} = 4 * k * T \frac{4}{3 * gm_{12}} * \left(1 + \sqrt{\frac{\mu_p * W/L_{34}}{\mu_n * W/L_{12}}}\right) * \Delta f$$
 (4.10)

$$\overline{v_{1/f}^2} = \frac{2 * K_n}{s * W_{12} * L_{12} * C_{ox}} * \left(1 + \frac{K_p * \mu_p * L_{12}^2}{K_n * \mu_n * L_{34}^2}\right)$$
(4.11)

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where  $gm_{12}$  is the transconductance of transistor M1 and M2 in figure 4.4, W is the width of the transistor, L is the length,  $K_n$  and  $K_p$  is flicker noise coefficients for n- and p-channel devices,  $\mu_n$  and  $\mu_p$  is the permeability for n- and p-channel devices and  $C_{ox}$  is the oxide capacitance. The differential pair is balanced, hence the W, L and gm are the same for transistor M1 and M2. Transistor M3 and M4 has also the same W, L and gm [9].

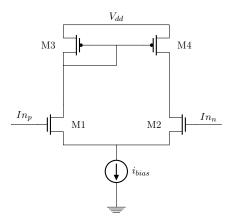
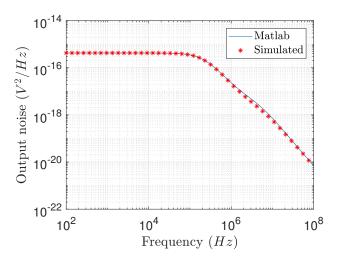


Figure 4.4

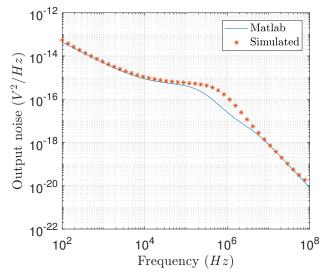
The voltage transfer function for the filter in figure 2.7 was first derived neglecting the output impedance of the OP-amp as

$$H_v = \frac{C_2 * (s * C_1 * R_1 + 1)}{C_2 * (s * C_1 * R_1 + 1) + C_3 * (s * C_2 * R_1 + s * C_2 * R_2 * (C_1 * R_1 + 1) + s * C_1 * R_1 + 1)}$$
(4.12)

where  $C_1$ ,  $C_2$ ,  $R_1$  and  $R_2$  are from the active filter depicted in figure 2.7. Equation 4.12 was validated by disconnecting the OP-amp and plotting the output noise voltage for just the passive components (figure 4.5). It can be seen that the calculations correspond to the simulated values, however when the Op-amp was connected the calculations did not correspond to the simulated (figure 4.6).



**Figure 4.5:** Validation of transfer function for noise for the passive components.



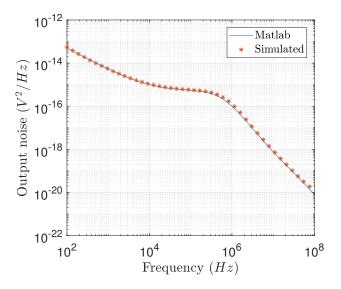
**Figure 4.6:** Validation of transfer function for noise for active filter without output impedance of OP-amp in the transfer function.

The transfer function was corrected for the output impedance of the OP-amp (equation 4.13) and validated (figure 4.7).

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$$H_v = \frac{s*C_2*R_1 + s*C_1*R_{op}*(s*C_1*R_1 + 1) + s*C_1*R_1 + 1)}{s*C_3*R_{op}*(s*C_2*R_1 + s*C_1*R_1 + 1) + (s*C_3*R_2 + 1)*(s*C_2*R_1 + s*C_2*R_{op}*(s*C_1*R_1 + 1) + s*C_1*R_1 + 1)} \tag{4.13}$$

where  $R_{op}$  is the output impedance of the OP-amp.

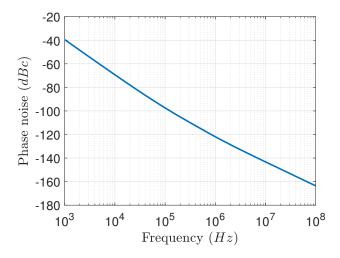


**Figure 4.7:** Validation of transfer function for noise for active filter, correcting for output impedance of OP-amp in the transfer function.

### 4.2.3 VCO

The phase noise of the VCO is not parameterized but is instead simulated for each design case.





**Figure 4.8:** Phase noise from VCO when transmitting on band 25 (VCO frequency 3765 MHz)

### 4.2.4 $\Delta\Sigma$ Converter

The noise introduced by the  $\Delta\Sigma$  converter was parameterized as suggested by [12].

$$\mathcal{L}(f) = 2 * \frac{(2 * \pi)^2}{12 * F_{ref}} * 2 * \sin\left(\frac{\pi * f}{F_{ref}}\right)^{2 * (m-1)} * \left(\frac{N}{N_{fixed}}\right)^2$$
(4.14)

where m is the order of the  $\Delta\Sigma$  converter,  $F_{ref}$  is the reference frequency, N is the division ratio and  $N_{fixed}$  is the divider prior to the  $\Delta\Sigma$  converter from figure 4.1.

### 4.2.5 XO

The XO specifications are Arm specific and are covered by a non-disclosure agreement. The reference frequency phase noise used for this work are made up values given by Arm typical for an XO and are presented in table 4.1.

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Frequency $Hz$	Phase noise $dB$
100	-113
1 K	-131
10 K	-143
100 K	-153
1 M	-163
10 M	-165

**Table 4.1:** Table presenting made up phase noise values for the crystal oscillator given by Arm.

### 4.2.6 Total PLL noise

By multiplying the given noise with its corresponding transfer function in square and dividing by two (in order to get phase noise from amplitude and phase noise) the total output noise for each block can be calculated for the PLL.

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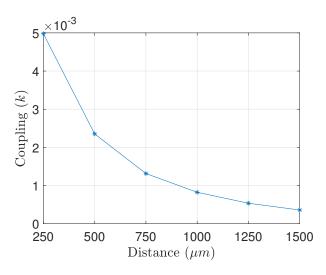
\_\_\_\_\_ Chapter 5

Pulling assessment

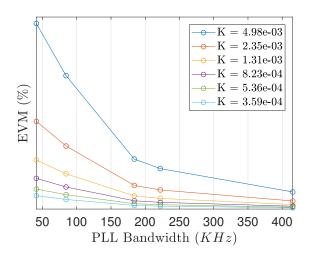
As presented in section 2.7, pulling of the VCO occurs when there is a signal with frequency close to the VCO frequency present. As the operating frequency of the VCO is twice of the transmitting frequency, second order harmonics from the PA might lead to pulling. The second order harmonics have to be investigated both on the primary and secondary side of the balun. As the PA is constructed using a differential topology, the second order harmonic on the secondary side of the balun should in theory be suppressed. In a real scenario, second order harmonics will be present due to mismatching in the PA and balun.

# 5.1 Pulling

In order to get a feel for the pulling effect for different bandwidths of the PLL, the pulling effect was calculated using equation 2.19 with  $i_2$  set to 1 A. To calculate  $I_2$ , real I and Q data were used to generate  $A_{BB}^2$  and  $\Theta_{BB}$ . The RMS value of  $A_{BB}^2(t)*sin(2*\theta_{BB}(t))$  was normalized prior to multiplying with the measured coupling from simulations. These measurements were measured at different distances between the balun and the VCO inductor to estimate the pulling effect with regards to distance (figure 5.1). By integrating the result of equation 2.19 from 2 Hz to the bandwidth of the envelope (90 KHz for NB-IoT) and combining equation 2.9 in 2.19 the EVM degradation due to frequency pulling of the VCO for different bandwidths could be made (figure 5.2). As this presents the pulling with a current of 1 A, the magnitude of the EVM degradation is not of interest, rather it is the characteristics of the EVM curve that is of interest.



**Figure 5.1:** Coupling as a function of distance edge to edge between the PA transformer and the VCO inductor. Measured using the electromagnetic simulator EMX.



**Figure 5.2:** EVM degradation characteristics as a function of bandwidth due to pulling.

From the characteristics of the EVM curves presented in figure 5.2 it is evident that reducing the coupling in addition to increasing the bandwidth of the PLL limits the effect of pulling. As the slope of the EVM curve is highest for bandwidths lower than 180 KHz, the reduction of EVM impairment has highest impact when the bandwidth is set to at least 180 KHz (two times the base band frequency).

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There are different approaches to mitigate the pulling; increasing the bias current of the VCO, increasing the Q of the VCO, increasing the bandwidth of the PLL and reducing the coupling between PA balun and VCO inductor. Increasing the bias current of the VCO is not an approach welcomed by Arm as it will increase the power consumption of the transceiver, in fact the power consumption should be reduced and hence the bias current will be kept at the lowest setting for the existing solution throughout this work.

### 5.2 Inductor design

As mentioned in section 5.1, one way of mitigating the pulling is to increase the bandwidth of the PLL. In order to do so, the phase noise has to be kept below the limits set by the NB-IoT requirement calculated in chapter 3. Different approaches can be made to reduce the phase noise, where one is optimizing the inductor size. The phase noise can also be reduced by increasing the Q of the RF-tank, this will also reduce the pulling. Another approach to reduce the pulling is to construct an inductor in such a way that the coupling is minimized. With these aspects in mind different inductors was constructed in order to increase Q or to reduce coupling, but also to reduce phase noise in order to be able to further increase the bandwidth of the PLL. As presented in chapter 3, the toughest requirement to be fulfilled is for  $f_{VCO} = 3765 \ MHz$  and hence the optimal inductor size was simulated according with the analysis proceeding equation 2.16 and 2.17 for this frequency (figure 5.3). The simulations were based on the lowest bias setting in the VCO (3.2 mA).

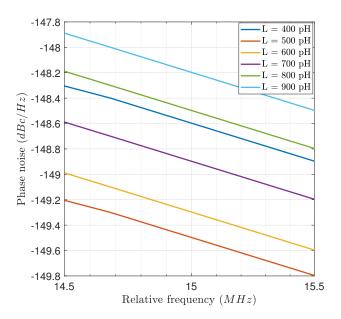


Figure 5.3: Phase noise versus inductor size at  $f_{VCO}=3765\ MHz$  at a relative frequency corresponding to band 25 with ideal capacitance.

From figure 5.3 it is evident that the best phase noise performance is when implementing the RF-tank in the VCO using an inductance of size 500 pH. The problem with reducing the size of the inductor is that the capacitance has to be reconfigured. Evaluating the size of the capacitance for a tuning range from 2.71 to 5.08 GHz for the original inductor (798 pH) compared to a 500 pH inductor:

$$\omega_0 = \frac{1}{\sqrt{LC}} = > \omega_0 = \frac{1}{\sqrt{L*(C_{tank} + C_x)}}$$
 (5.1)

where  $C_x$  is the capacitance in order to compensate for a smaller inductance and  $C_{tank}$  refers to the capacitance constituted by a digital controlled switched capacitance and a varactor.

$$L = 798 \ pH \ @ \ band \ 25; \ 3765MHz = \frac{1}{2\pi * \sqrt{798p * C_{tank}}} <=> C_{tank} = 2.24 \ pF$$
 (5.2)

Tuning range:

$$f_{min} = 2.71 \ GHz = > C_{tank} = 4.32 \ pF$$
 (5.3)

$$f_{max} = 5.08 \ GHz => C_{tank} = 1.23 \ pF$$
 (5.4)

This implies that the digital controlled capacitance is  $4.32~\mathrm{pF}$  -  $1.23~\mathrm{pF} = 3.09~\mathrm{pF}$ , assuming a constant capacitance not connected to the digital control logic of

1.23 pF.

$$L = 500 \ pH \ @ \ band \ 25; \ 3765MHz = \frac{1}{2\pi * \sqrt{500p * C_{tot}}} <=> C_{tot} = 3.57 \ pF$$

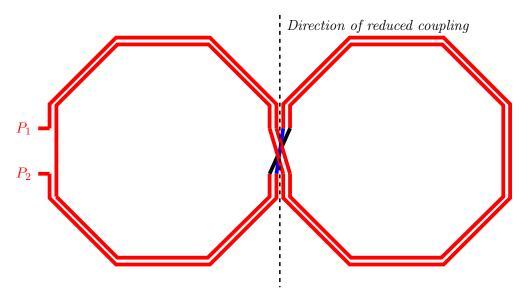
$$(5.5)$$

 $C_{tot} = C_{tank} + C_x, \langle = \rangle C_x = 1.33p$  Tuning range:

$$f_{min} = 2.71 \ GHz = \frac{1}{2\pi * \sqrt{500p * (C_{tank} + C_x)}} <=> C_{tank} = 5.57 \ pF \quad (5.6)$$

$$f_{max} = 5.08 \ GHz => C_{tank} = 0.63 \ pF$$
 (5.7)

This implies that the digital controlled capacitance is 5.57 pF - 0.63 pF = 4.94 pF, hence 4.94 pF - 3.09 pF = 1.85 pF bigger in order to maintain the same tuning range. The constant capacitance in this case also has to be changed  $C_x+0.63$  pF = 1.96 pF, which is 0.73 pF larger than for the case with the original inductor. Due to the need of redesign of the the capacitance in the RF-tank if a smaller inductor is used, two design approaches were made; one with an inductor of the same size as the original and one with an inductor of 500 pH. Furthermore, the coupling between inductors will be dominated by the magnetic coupling below the resonance frequency [24]. By constructing an inductor as proposed by [11] and [16] in an eight fashion as in figure 5.4, the coupling can be reduced in the direction of the center of the inductor (indicated in figure).

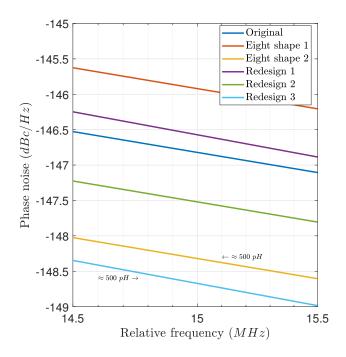


**Figure 5.4:** Sketch illustrating layout of eight shaped inductance with two windings.

Five different inductors were constructed and evaluated (table 5.1 and figure 5.5) where "Eight shape" refers to the shape of the inductor as presented in figure 5.4.

Design	L pH	$Q_{ind}$	$Q_{VCO}$	# Turns	Length $\mu m$	Height $\mu m$	# Cap
Original	798	15.8	9.9	2	164	145	84
Redesign 1	810	18.6	11.4	2	164	164	80
Redesign 2	670	17.2	10.5	2	145	145	118
Redesign 3	498	16.9	10.0	1	220	220	198
Eight shape 1	771	10.4	7.6	2	166	110	91
Eight shape 2	489	14.4	9.0	1	280	140	201

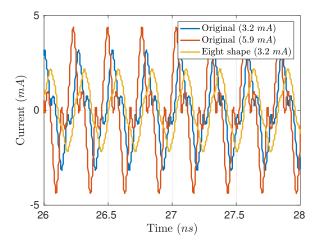
**Table 5.1:** Table presenting performance from different redesigns of the inductor in the VCO and corresponding digital control word for the capacitance to transmit on band 25.



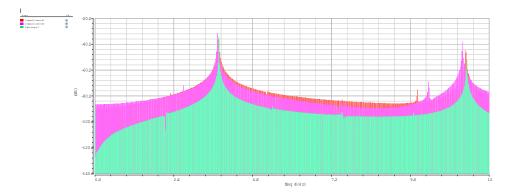
**Figure 5.5:** Phase noise for the VCO with  ${\it i}_{bias}=3.2$  mA at  $f_{VCO}=3765$  MHz measured at a relative frequency corresponding to the criterion set by band 25.

Looking into why the phase noise performance is reduced with the original inductor compared to using "Eight shape 2" even though the Q is higher for the original inductor, one can see that the shape of the current curve deviates from an ideal sinus curve when the original inductor is used. Increasing the bias current in the VCO is leading to higher deviation from an ideal sinus curve (figure 5.6). In figure 5.7 a DFT of the currents are presented. The frequency content for frequencies other than the center frequency for the original inductor is high, furthermore;

increasing the current does not improve the phase noise (figure 5.8). Observing these aspects, one can suspect that the transistors are current saturated when utilizing the original inductor for the bias current settings set by the original bias configuration.

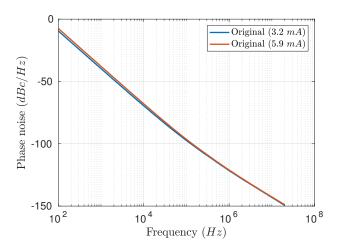


**Figure 5.6:** Current curves for the original inductor and the "Eight shaped 2" inductor.



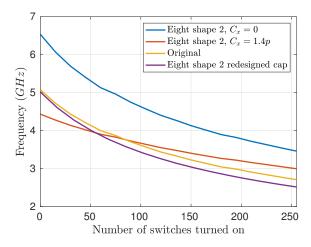
**Figure 5.7:** DFT of current curves from VCO where green is when using the "Eight shape 2" inductor with 3,2 mA bias current, orange is the original inductor with 3,2 mA bias current and pink is original inductor with 5.9 mA bias current.





**Figure 5.8:** Phase noise for two different bias settings using the original inductor.

As the phase noise performance was improved when using an inductor of 500 pH, the capacitance had to be changed in accordance with discussion regarding equation 5.1 - 5.7. The tuning characteristics for the "Eight shape 2" inductor compared to the original is presented in figure 5.9.



**Figure 5.9:** Tuning range for VCO with original inductor compared with Eight shape 2.

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### 5.3 Balun design

As mentioned in section 5.1, the pulling can be reduced by reducing the coupling between PA balun and VCO inductor. This calls for a redesign of the balun in order to minimize this coupling without jeopardizing the performance of the PA.

In order to maximize the coupling in the balun (between primary and secondary side) and still be able to handle the high current generated in the PA, the balun was constructed as presented in figure 5.10. By doing this, the secondary winding constitutes of one conductor and the primary of two conductors. The width of the primary winding will be two times as wide as the two conductors are short circuited, giving it a higher robustness. By placing the secondary conductor between the primary conductors the coupling is increased. The lowest Z-layer up to and including top layer was used in order to increase robustness and coupling. Extensive theory regarding the PA is outside the scope of this thesis but it is worth mentioning that the load of the PA has to be kept low in order to deliver a high power and achieve a satisfying power added efficiency (PAE) [9]. As the load of the antenna is 50 Ohm, the antenna load has to be transformed to a lower value. The load of the PA is given by:

$$Z_{PA} = \frac{L_p}{L_s} * Z_L, \tag{5.8}$$

where  $Z_{PA}$  is the load seen by the PA,  $L_p$  is the inductance of the primary side of the transformer,  $L_s$  is the inductance of the secondary side of the transformer and  $Z_L$  is the load of the antenna. In order to keep the load low, the number of secondary turns will be kept to two times the primary turns.

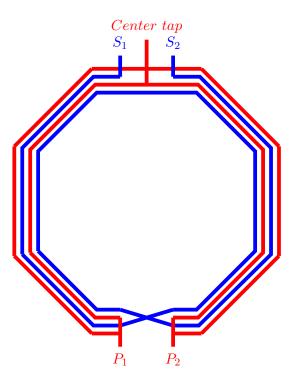


Figure 5.10: Sketch illustrating layout of balun.

The initial design of the balun was constructed using one turn on the primary side and two on the secondary (figure 5.10). Due to the differential topology, the second order current on the secondary side will be the difference between  $P_1$  and  $P_2$ . In theory this current is zero but due to asymmetry, different load connected to  $S_1$  and  $S_2$  (in fact, one will be connected to the antenna and the other will be grounded) and mismatching in the PA some second order current can be expected on the secondary side. On the primary side, the current will be in phase at  $P_1$  and  $P_2$  and hence the current seen in far field will be the sum of the two. As this current is much higher than the current seen on the secondary side, focus will be on investigating the coupling from the primary side to a VCO inductor.

Evaluating the balun in figure 5.10, it is evident that the current will flow from  $P_1$  and  $P_2$  to Center tap generating a magnetic field. Increasing the number of windings to two will cancel this field as the current flowing back in the second winding will cancel the current flowing in the first (figure 5.11) making the current look like zero when the distance is larger than at least the width of two conductors in the balun. This balun was implemented overlooking the current flowing in the center tap generating a magnetic field, this called for another redesign of the balun in order to further reduce the coupling.

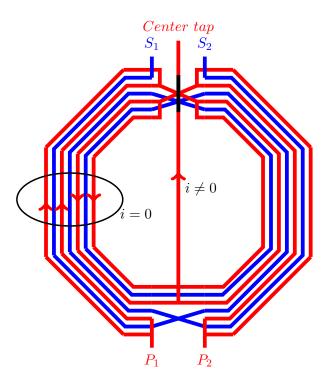


Figure 5.11: Sketch illustrating layout of redesign balun.

By changing the direction of the center tap in the topology presented in figure 5.10, the return path of the current flowing in the center tap will be opposite to the current flowing in the conductors from  $P_1$  and  $P_2$  (figure 5.12). This will further suppress the coupling from the balun to the VCO but the distance between the center tap to the conductors will lead to some magnetic field being generated. By adopting the idea of the topology with two windings (figure 5.11) and changing the direction of the center tap, the magnetic field generated by the balun could be further suppressed (figure 5.13).

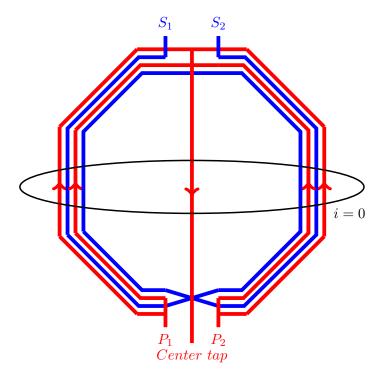
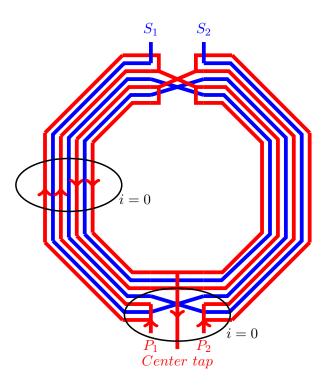


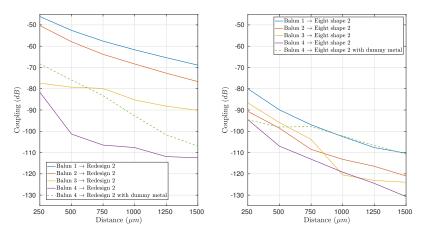
Figure 5.12: Sketch illustrating layout of balun with new center tap.



**Figure 5.13:** Sketch illustrating layout of balun with two windings and new center tap.

The coupling for all the baluns was simulated for different distances (edge to edge) and are presented in figure 5.14. It can be argued that simulating the coupling between the balun and the inductor with nothing in between is not a valid case as this is not true for the real chip. In order to get a better understanding for the coupling, a simulation was made with a dummy metal plate between the balun and the inductor. This metal plate filled the space between the inductor and the balun up to a distance of  $20~\mu m$  to the edges.





**Figure 5.14:** Coupling from the baluns to different inductors as a function of distance (edge to edge). The indexing of each balun is presented in table 5.2.

Balun	Figure	Insertion Loss @ 2 GHz (dB)
1	5.10	0.7345
2	5.11	0.8335
3	5.12	0.8663
4	5.13	0.8720

Table 5.2

# 5.4 Increasing PLL bandwidth

As discussed in section 5.1, the effect of the pulling is suppressed if the PLL bandwidth is high, especially when it is higher than two times the base band frequency. This section aims to increase the bandwidth as much as possible and still be able to fulfill the NB-IoT criterion. Figure 5.15 presents what effects to expect when increasing the PLL bandwidth. As one can see, a high bandwidth leads to low suppression of  $\Delta\Sigma$  noise. To have a higher bandwidth then two times the base band frequency and still have some phase noise headroom a bandwidth of 220 KHz (figure 5.16) was a good trade of, Arm is requesting a 10 dB headroom. Having a slightly higher bandwidth than two times the base band frequency leaves room for reduced bandwidth due to temperature and process variations.

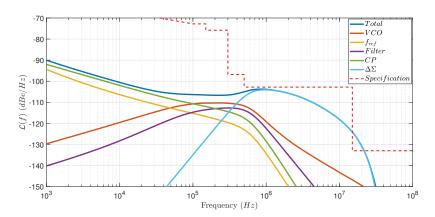


Figure 5.15: Bw = 400 KHz

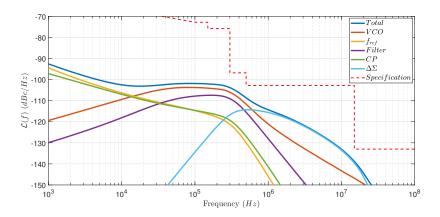


Figure 5.16: Bw = 220 KHz

By changing  $N_{fixed}$  from two to one, the resolution of the  $\Delta\Sigma$  modulator is increased. This will reduce the phase noise from the  $\Delta\Sigma$  modulator by 6 dB (figure 5.18). In order to validate this approach to increase the resolution, the performance of the divider had to be evaluated. This was done in the simulator and the results are presented in figure 5.17. By investigating the output from the divider, one can see that changing  $N_{fixed}$  to one is not jeopardizing the performance.

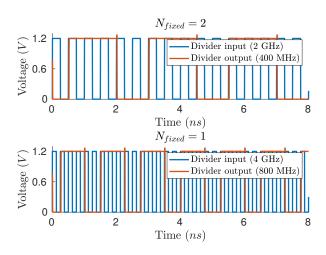


Figure 5.17: Validation of divider performance for  $N_{fixed}=1.$ 

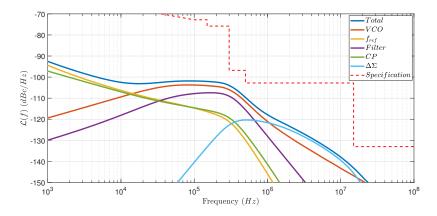


Figure 5.18: Bw = 220 KHz and  $N_{fixed}=1.$ 

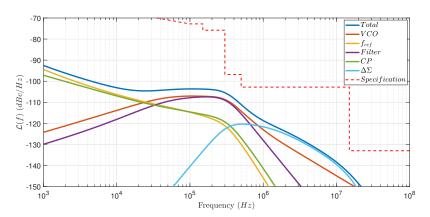


Figure 5.19: Bw = 220 KHz and  $N_{fixed}=1$  with eight shape 2 as inductor.

From equation 3.11 and 3.12, the EVM degradation due to the PLL phase noise is 0.3~%.

### 5.5 Pulling revisited

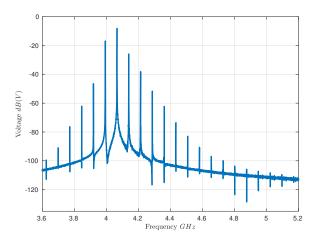
### 5.5.1 Setting up test bench for pulling analysis

To investigate the effects of frequency pulling of the VCO, a large signal time domain simulation was made. Using an S-parameter file generated by an electromagnetic simulator (EMX) for this case is not feasible as the S-parameter file has to be very detailed in order to get reliable results. Also, running the simulation with an S-parameter file will be extremely time consuming. To reduce the complexity of this simulation a schematic model of the balun was generated using EMX. In this model, coupling to the VCO inductor was generated with an "sp - simulation" to mimic the coupling measured using the N-port for the simulated coupling presented in figure 5.14. The VCO used in the test bench (TB) was the actual PLL VCO apart from the inductor, where an inductor from Cadence standard library "AnalogLib" with the same inductance and Q-value as the inductor intended for the test case was used. Two parallel circuits constituting of one capacitance, one resistance and one current source were connected to each side of the model of the balun. The capacitance and resistance are to mimic the impedance of the PA and was simulated with the PA in deep compression. The current source is the current going into the balun from the PA. Inspecting this current, one can detect a slight difference between the two sides of the PA. This common mode mismatch is due to asymmetries in the balun as well as one side of the secondary side being loaded with 50  $\Omega$  (antenna load) and the other being grounded. If the current in the TB would correspond to the current measured with the actual balun, this mismatch would be accounted for twice as the asymmetry is included in the generated EMX model. In order to measure what current to set in the TB, another TB was set up with a balun constructed with Cadence Virtuoso standard library "AnalogLib" components with the same parameters as for the true balun. The current measured in this TB had no common mode mismatch and could be used in the TB for evaluating the effects of frequency pulling of the VCO.

To achieve a high resolution DFT, the offset of the VCO and the interferer has to be an integer multiple of the inverse of the simulation time. To ensure an integer multiple, the VCO was frequency locked. In order to attain an accurate approximation of the pulling effect for a free running VCO, the injected current to lock the VCO with was low but high enough to get the same voltage swing as for the VCO when free running. Also, the phase noise characteristics was investigated and an interfering offset was chosen to be higher than when the phase noise characteristics for the locked VCO is same as for the free running.

### 5.5.1.1 Pulling

Starting with the worst case; balun 1 as aggressor and redesign 2 as victim with a distance of 250  $\mu$ m, one can detect from the characteristics of the DFT in figure 5.20 and the theory presented on frequency pulling of VCO (subsection 2.6.2) that the VCO is in "quasi lock". For ideal performance of the VCO, the voltage swing should be constant. Looking into the voltage characteristics for this case (figure 5.21), it is evident that the voltage swing is deteriorated. Without further investigation it can be concluded that the performance of the transceiver is ruined for this case due to the impairments of the VCO.



**Figure 5.20:** DFT of VCO output with balun 1 as aggressor and redesign 2 as victim with a distance of 250  $\mu$ m

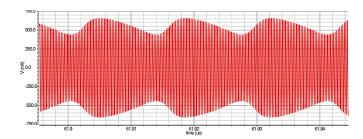
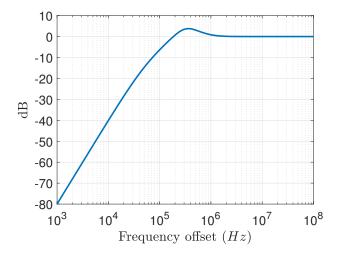
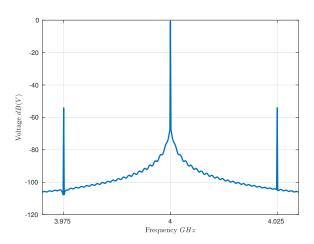


Figure 5.21: Voltage characteristic of VCO with balun 1 as aggressor and redesign 2 as victim with a distance of 250  $\mu m$ 

Looking into the performance with balun 4 as aggressor and redesign 2 as victim with a distance of 1000  $\mu$ m with dummy metal, one can detect the sidebands at a 25 MHz offset from the VCO (5.23). These sidebands have to be recalculated to a frequency inside the frequency of the baseband using equation 2.18. From the frequency shifted sidebands, the relative magnitude of the sidebands can be calculated. Recalculating the sideband to 90 KHz using equation 2.18, the relative magnitude will be -4.5 dB. The effect of pulling for the closed loop PLL can then be calculated through the closed loop transfer function of the pulling  $\frac{1}{1+H_{ol}}$  [3], presented in figure 5.22. The suppression of the pulling when the bandwidth is 220 KHz is -7.6 dB, this results in a relative harmonic of -12.1 dBc. One can argue that this interferer is not well outside the frequency locking range and hence equation 2.18 is not valid. Regardless whether or not equation 2.18 hold, the performance is ruined for this case. Looking at table 3.3 one can see that -12.1 dB would validate the EVM criterion; if the equation does not hold the VCO is most likely in a quasi lock or frequency locked state.



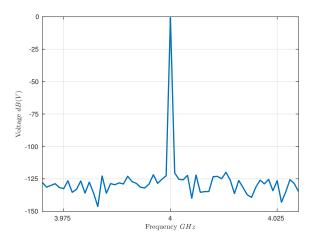
**Figure 5.22:** Transfer function for the frequency pulling injected into the VCO, Bw = 220 KHz.



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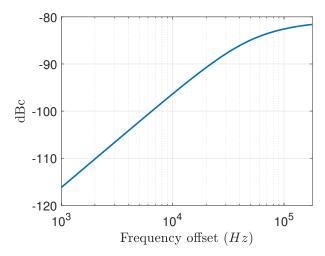
Figure 5.23: DFT of VCO output with balun 4 as aggressor and redesign 2 as victim with a distance of 1000  $\mu \rm m$  and dummy metal

With balun 4 as aggressor and eight shape 2 as victim with a distance of 1000  $\mu$ m with dummy metal, the effect of pulling is below the noise floor in the DFT (figure 5.24). The maximum possible magnitude of the sideband is hence -125 dB (the level of the noise floor), recalculating this in accordance with equation 2.18 results in a relative sideband of -75.3 dB at a 90 KHz offset to the VCO frequency. After taking the suppression of the PLL into account, the relative harmonic is -82.9 dBc. From table 3.3 one can see that this is well inside the EVM criterion.



**Figure 5.24:** DFT of VCO output with balun 4 as aggressor and eight shape 2 as victim with a distance of 1000  $\mu$ m and dummy metal

Looking at the characteristics of the transfer function presented in figure 5.22, it can be found that the suppression corresponds to a  $1/f^2$  slope. The magnitude of the relative sidebands due to pulling (equation 2.18) increases with 1/f, hence the worst case for pulling is when the frequency offset is maximized as shown in figure 5.25. The bandwidth of the baseband signal for NB-IoT is 90 KHz; as the second order harmonic is the interfering signal, the maximum offset will be two times the baseband signal.



**Figure 5.25:** Magnitude of PLL sidebands due to pulling as a function of frequency offset with balun 4 as aggressor and eight shape 2 as victim with a distance of 1000  $\mu$ m and dummy metal and a PLL bandwidth of 220 KHz.

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\_\_\_\_\_ Chapter **6** 

# Conclusion

This thesis has presented a working solution for the PLL with an integrated PA. This has been done through design aspects for how to mitigate coupling between the PA balun and the VCO inductor and how to increase the bandwidth of the PLL without violating the NB-IoT requirement set by 3GPP. Furthermore the phase noise performance of the VCO has been increased and the critical operation band for the transceiver has been identified.

Looking at the thesis objectives (Section 1.2), the purpose of this thesis is fulfilled.

### 6.1 Future work

- Changing the PA from a linear architecture to a switched architecture changes the demand on the PLL. A future task could be to prepare the PLL for a transaction to a switched architecture.
- The requirement for receiving is much more relaxed than for transmitting, also the PA is not causing any pulling when receiving. This calls for an investigation if the transceiver can be run in a low power mode when receiving in order to save battery lifetime.
- Different PLL architectures with a different divide number following the PLL could be evaluated to mitigate the pulling from the PA.
- Looking into the charge pump and loop filter; the charge pump could be redesigned in order to enable the usage of a passive loop filter.
- Evaluate the worst allowed performance for the XO in order reduce cost and power consumption.
- Manufacture and measure the performance of the circuit.

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